SCLS229D - OCTOBER 1995 - REVISED JUNE 1997

- Inputs Are TTL-Voltage Compatible
- *EPIC*[™] (Enhanced-Performance Implanted CMOS) Process
- High Latch-Up Immunity Exceeds 250 mA Per JESD 17
- ESD Protection Exceeds 2000 V Per MIL-STD-883, Method 3015; Exceeds 200 V Using Machine Model (C = 200 pF, R = 0)
- Package Options Include Plastic Small-Outline (D), Shrink Small-Outline (DB), Thin Very Small-Outline (DGV), Thin Shrink Small-Outline (PW), and Ceramic Flat (W) Packages, Ceramic Chip Carriers (FK), and Standard Plastic (N) and Ceramic (J) 300-mil DIPs

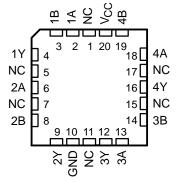
description

The 'AHCT00 perform the Boolean function $Y = \overline{A \bullet B}$ or $Y = \overline{A} + \overline{B}$ in positive logic.

The SN54AHCT00 is characterized for operation over the full military temperature range of -55° C to 125°C. The SN74AHCT00 is characterized for operation from -40° C to 85° C.

SN54AHCT00 . . . J OR W PACKAGE SN74AHCT00 . . . D, DB, DGV, N, OR PW PACKAGE (TOP VIEW)

SN54AHCT00 . . . FK PACKAGE (TOP VIEW)



NC - No internal connection

EPIC is a

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PRODUCTION DATA information is current as of publication date. Products conform to specifications per the terms of Texas Instruments standard warranty. Production processing does not necessarily include testing of all parameters.



FUNCTION TABLE (each gate)

в

н

Х

L

OUTPUT Y

L

н

н

INPUTS

Α

н

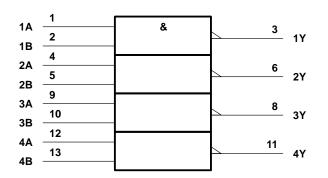
L

Х

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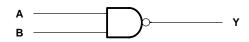
SCLS229D - OCTOBER 1995 - REVISED JUNE 1997

logic symbol[†]



[†] This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12. Pin numbers shown are for D, DB, DGV, J, N, PW, and W packages.

logic diagram (positive logic)



absolute maximum ratings over operating free-air temperature range (unless otherwise noted)[‡]

Supply voltage range, V_{CC} Input voltage range, V_I (see Note 1) Output voltage range, V_O (see Note 1) Input clamp current, I_{IK} ($V_I < 0$) Output clamp current, I_{OK} ($V_O < 0$ or $V_O > V_O$ Continuous output current, I_O ($V_O = 0$ to V_{CC} Continuous current through V_{CC} or GND Package thermal impedance, θ_{JA} (see Note 2)	CC) 2): D package DB package DGV package N package	$\begin{array}{c} -0.5 \mbox{ V to 7 V} \\ -0.5 \mbox{ V to V}_{CC} + 0.5 \mbox{ V} \\ -20 \mbox{ mA} \\ \pm 20 \mbox{ mA} \\ \pm 25 \mbox{ mA} \\ \pm 50 \mbox{ mA} \\ 127 \mbox{ °C/W} \\ 158 \mbox{ °C/W} \\ -182 \mbox{ °C/W} \\ -78 \mbox{ °C/W} \\ \end{array}$
Storage temperature range, T _{sta}	PW package	170°C/W
5		

Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

2. The package thermal impedance is calculated in accordance with JESD 51, except for through-hole packages, which use a trace length of zero.



SCLS229D - OCTOBER 1995 - REVISED JUNE 1997

recommended operating conditions (see Note 3)

		SN54AHCT00		CT00 SN74AHCT00		UNIT
		MIN	MAX	MIN	MAX	UNIT
VCC	Supply voltage	4.5	5.5	4.5	5.5	V
VIH	High-level input voltage	2		2		V
VIL	Low-level input voltage		0.8		0.8	V
VI	Input voltage	0	5.5	0	5.5	V
VO	Output voltage	0	VCC	0	VCC	V
ЮН	High-level output current		-8		-8	mA
IOL	Low-level output current		8		8	mA
$\Delta t/\Delta v$	Input transition rise or fall rate		20		20	ns/V
Т _А	Operating free-air temperature	-55	125	-40	85	°C

NOTE 3: Unused inputs must be held high or low to prevent them from floating.

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS	TEST CONDITIONS		T _A = 25°C			SN54AHCT00		SN74AHCT00		UNIT
PARAMETER	TEST CONDITIONS	Vcc	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNIT	
Veu	I _{OH} = -50 μA	4.5 V	4.4	4.5		4.4		4.4		V	
Voh	I _{OH} = -8 mA	4.5 V	3.94			3.8		3.8		v	
Ve	I _{OL} = 50 μA	4.5 V			0.1		0.1		0.1	V	
V _{OL}	I _{OL} = 8 mA				0.36		0.44		0.44	v	
Ц	$V_{I} = V_{CC}$ or GND	5.5 V			±0.1		±1		±1	μΑ	
ICC	$V_{I} = V_{CC} \text{ or } GND, \qquad I_{O} = 0$	5.5 V			2		20		20	μA	
∆lcc‡	One input at 3.4 V, Other inputs at V _{CC} or GND	5.5 V			1.35		1.5		1.5	mA	
Ci	$V_I = V_{CC}$ or GND	5 V		2	10				10	pF	

[†] This is the increase in supply current for each input at one of the specified TTL voltage levels rather than 0 V or V_{CC}.

switching characteristics over recommended operating free-air temperature range, V_{CC} = 5 V \pm 0.5 V (unless otherwise noted) (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)		T _A = 25°C			MIN		UNIT
	(MIN	TYP	MAX		MAX	
^t PLH [*]	A or B	V	Cu - 15 pE		5	6.9	1	8	
^t PHL [*]	AUB	T	C _L = 15 pF		5	6.9	1	8	ns
^t PLH	A or B	V	$C_{\rm L} = 50 \rm pE$		5.5	7.9	1	9	ns
^t PHL	AOIB	I	C _L = 50 pF		5.5	7.9	1	9	115

* On products compliant to MIL-PRF-38535, this parameter is ensured but not production tested.



SCLS229D - OCTOBER 1995 - REVISED JUNE 1997

switching characteristics over recommended operating free-air temperature range, V_{CC} = 5 V \pm 0.5 V (unless otherwise noted) (see Figure 1)

					SN	74AHCT	00		
PARAMETER	FROM (INPUT)	TO (OUTPUT)	LOAD CAPACITANCE	Τ ₄	∖ = 25°C	;	MIN	МАХ	UNIT
	((0011 01)		MIN	TYP	MAX			
^t PLH	A or B	V	CL = 15 pF		5	6.9	1	8	200
^t PHL	AUB			5	6.9	1	8	ns	
^t PLH	A or P	v	$C_{\rm L} = 50 \rm pE$		5.5	7.9	1	9	
^t PHL	A or B	T	CL = 50 pF		5.5	7.9	1	9	ns

noise characteristics, V_{CC} = 5 V, C_L = 50 pF, T_A = 25°C (see Note 4)

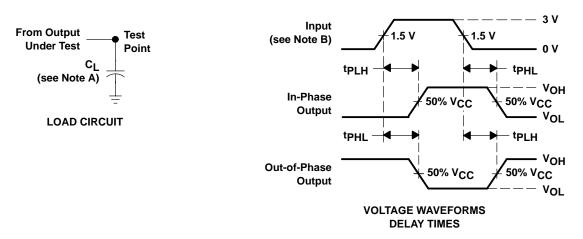
	PARAMETER		SN74AHCT00			
			TYP	MAX	UNIT	
V _{OL(P)}	Quiet output, maximum dynamic V _{OL}		0.4	0.8	V	
VOL(V)	Quiet output, minimum dynamic V _{OL}		-0.4	-0.8	V	
VOH(V)	Quiet output, minimum dynamic V _{OH}		4.5		V	
VIH(D)	High-level dynamic input voltage	2			V	
V _{IL(D)}	Low-level dynamic input voltage			0.8	V	

NOTE 4: Characteristics are determined during product characterization and ensured by design for surface-mount packages only.

operating characteristics, $V_{CC} = 5 V$, $T_A = 25^{\circ}C$

	PARAMETER		NDITIONS	TYP	UNIT
C _{pd}	Power dissipation capacitance	No load,	f = 1 MHz	10.5	pF

PARAMETER MEASUREMENT INFORMATION



NOTES: A. C_L includes probe and jig capacitance.

- B. Input pulses are supplied by generators having the following characteristics: PRR \leq 1 MHz, Z_O = 50 Ω , t_f = 3 ns, t_f = 3 ns.
- C. The outputs are measured one at a time with one input transition per measurement.

Figure 1. Load Circuit and Voltage Waveforms



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